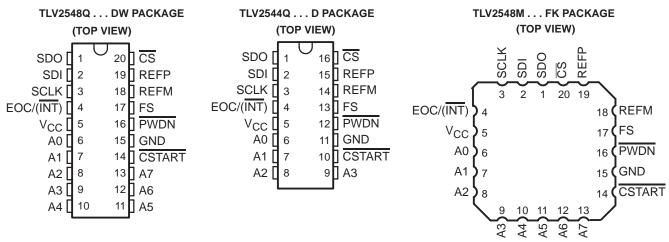
- Maximum Throughput 200-KSPS
- Built-In Reference, Conversion Clock and 8× FIFO
- Differential/Integral Nonlinearity Error: ±1.2 LSB at -55°C to 125°C
- Signal-to-Noise and Distortion Ratio: 65 dB, f<sub>i</sub> = 12-kHz at -55°C to 125°C
- Spurious Free Dynamic Range: 75 dB, f<sub>i</sub> = 12- kHz
- SPI/DSP-Compatible Serial Interfaces With SCLK up to 20-MHz
- Single Wide Range Supply 3 Vdc to 5.5 Vdc
- Analog Input Range 0-V to Supply Voltage With 500 kHz BW

- Hardware Controlled and Programmable Sampling Period
- Low Operating Current (1-mA at 3.3-V, 2-mA at 5.5-V With External Ref, 1.7-mA at 3.3-V, 2.4-mA at 5.5-V With Internal Ref)
- Power Down: Software/Hardware Power-Down Mode (1 μA Typ, Ext Ref), Autopower-Down Mode (1 μA Typ, Ext Ref)
- Programmable Auto-Channel Sweep
- Available in Q-Temp Automotive High Reliability Automotive Applications Configuration Control/Print Support Qualification to Automotive Standards



#### description

The TLV2544Q, TLV2548Q, and TLV2548M are a family of high performance, 12-bit low power, 3.5  $\mu$ s, CMOS analog-to-digital converters (ADC) which operate from a single 3-V to 5.5-V power supply. These devices have three digital inputs and a 3-state output [chip select ( $\overline{CS}$ ), serial input-output clock (SCLK), serial data input (SDI), and serial data output (SDO)] that provide a direct 4-wire interface to the serial port of most popular host microprocessors (SPI interface). When interfaced with a DSP, a frame sync (FS) signal is used to indicate the start of a serial data frame.



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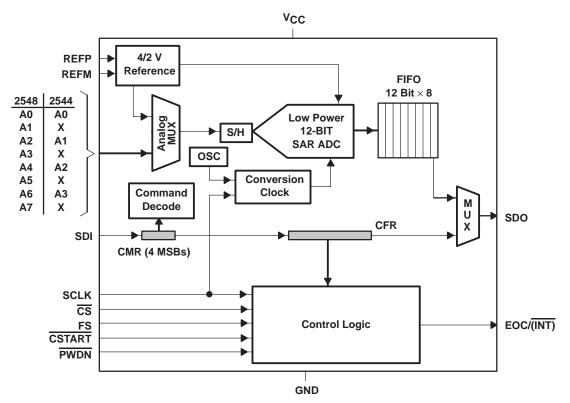
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#### description (continued)

In addition to a high-speed A/D converter and versatile control capability, these devices have an on-chip analog multiplexer that can select any analog inputs or one of three internal self-test voltages. The sample-and-hold function is automatically started after the fourth SCLK edge (normal sampling) or can be controlled by a special pin, CSTART, to extend the sampling period (extended sampling). The normal sampling period can also be programmed as short (12 SCLKs) or as long (24 SCLKs) to accommodate faster SCLK operation popular among high-performance signal processors. The TLV2548 and TLV2544 are designed to operate with very low power consumption. The power-saving feature is further enhanced with software/hardware/autopower-down modes and programmable conversion speeds. The conversion clock (OSC) and reference are built-in. The converter can use the external SCLK as the source of the conversion clock to achieve higher (up to 2.8 µs when a 20 MHz SCLK is used) conversion speed. Two different internal reference voltages are available. An optional external reference can also be used to achieve maximum flexibility.

The TLV2544Q and the TLV2548Q are characterized for operation from -40°C to 125°C. The TLV2548M is characterized for operation from -55°C to 125°C.



#### functional block diagram

| AVAIL | ABLE | OPTIONS |
|-------|------|---------|
|       |      |         |

| TA             | 20-SOIC<br>(DW) | 16-SOIC<br>(D) | 20-LCCC<br>(FK) |
|----------------|-----------------|----------------|-----------------|
| –40°C to 125°C | TLV2548QDW      | TLV2544QD      | —               |
| –55°C to 125°C | —               | _              | TLV2548MFK      |



#### **Terminal Functions**

| TERMINAL                      |             |                           |     |   |  |
|-------------------------------|-------------|---------------------------|-----|---|--|
| NAME                          | NO.         |                           | I/O | DESCRIPTION   |  |
|                               | TLV2544     | TLV2548                   |     |   |  |
| A0 A0<br>A1 A1<br>A2 A2       | 6<br>7<br>8 | 6<br>7<br>8               | I   | Analog signal inputs. The analog inputs are applied to these terminals and are internally multiplexed. The driving source impedance should be less than or equal to 1 k $\Omega$ .  |  |
| A3 A3<br>A4<br>A5<br>A6<br>A7 | 9           | 9<br>10<br>11<br>12<br>13 |     | For a source impedance greater than 1 k $\Omega$ , use the asynchronous conversion start signal CSTART (CSTART low time controls the sampling period) or program long sampling period to increase the sampling time.  |  |
| CS                            | 16          | 20                        | I   | Chip select. A high-to-low transition on the $\overline{CS}$ input resets the internal 4-bit counter, enables SDI, and removes SDO from 3-state within a maximum setup time. SDI is disabled within a setup time after the 4-bit counter counts to 16 (clock edges) or a low-to-high transition of $\overline{CS}$ whichever happens first.<br>NOTE: $\overline{CS}$ falling and rising edges need to happen when SCLK is low for a microprocessor interface such as SPI.   |  |
| CSTART                        | 10          | 14                        | I   | This terminal controls the start of sampling of the analog input from a selected multiplex channel. Sampling time starts with the falling edge of $\overrightarrow{CSTART}$ and ends with the rising edge of $\overrightarrow{CSTART}$ as long as $\overrightarrow{CS}$ is held high. In mode 01, select cycle, $\overrightarrow{CSTART}$ can be issued as soon as CHANNEL is selected which means the fifth SCLK during the select cycle, but the effective sampling time is not started until $\overrightarrow{CS}$ goes to high. The rising edge of $\overrightarrow{CSTART}$ (when $\overrightarrow{CS}$ = 1) also starts the conversion. Tie this terminal to V <sub>CC</sub> if not used. |  |
| EOC/(INT)                     | 4           | 4                         | 0   | End of conversion or interrupt to host processor.<br>[PROGRAMMED AS EOC]: This output goes from a high-to-low logic level at the end of the<br>sampling period and remains low until the conversion is complete and data are ready for transfer.<br>EOC is used in conversion mode 00 only.<br>[PROGRAMMED AS INT]: This pin can also be programmed as an interrupt output signal to the host   |  |
|                               |             |                           |     | processor. The falling edge of $\overline{\text{INT}}$ indicates data are ready for output. The following $\overline{\text{CS}}\downarrow$ or $\overline{\text{FS}}$ clears $\overline{\text{INT}}$ .   |  |
| FS                            | 13          | 17                        | I   | DSP frame sync input. Indication of the start of a serial data frame in or out of the device. If FS remains low after the falling edge of CS, SDI is not enabled until an active FS is presented. A high-to-low transition on the FS input resets the internal 4-bit counter and enables SDI within a maximum setup time. SDI is disabled within a setup time after the 4-bit counter counts to 16 (clock edges) or a low-to-high transition of CS whichever happens first.   |  |
|                               |             |                           |     | Tie this terminal to $V_{CC}$ if not used. NOTE: The current silicon will react to FS input irrespective of the state of $\overline{CS}$ signal.  |  |
| GND                           | 11          | 15                        | I   | Ground return for the internal circuitry. Unless otherwise noted, all voltage measurements are with respect to GND.   |  |
| PWDN                          | 12          | 16                        | I   | Both analog and reference circuits are powered down when this pin is at logic zero. The device can be restarted by active CS, FS or CSTART after this pin is pulled back to logic one.  |  |
| SCLK                          | 3           | 3                         | I   | Input serial clock. This terminal receives the serial SCLK from the host processor. SCLK is used to clock the input SDI to the input register. When programmed, it may also be used as the source of the conversion clock.<br>NOTE: This device supports CPOL (clock polarity) = 0, which is SCLK returns to zero when idling for SPI compatible interface.   |  |
| SDI                           | 2           | 2                         | Ι   | Serial data input. The input data is presented with the MSB (D15) first. The first 4-bit MSBs, D(15–12) are decoded as one of the 16 commands (12 only for the TLV2544). The configure write commands require an additional 12 bits of data. When FS is not used (FS =1), the first MSB (D15) is expected after the falling edge of CS and is latched in on the rising edges of SCLK (after $\overline{CS}\downarrow$ ). When FS is used (typical with an active FS from a DSP) the first MSB (D15) is expected after the falling edge of FS and is latched in on the falling edges of SCLK.  |  |

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#### **Terminal Functions (Continued)**

| TERMINAL |          | TERMINAL |                 |   |  |
|----------|----------|----------|-----------------|---|--|
| NAME     | NAME NO. |          | I/O DESCRIPTION |   |  |
| NAIVIE   | TLV2544  | TLV2548  |                 |   |  |
| SDO      | 1        | 1        | 0               | The 3-state serial output for the A/D conversion result. SDO is kept in the high-impedance state when $\overline{CS}$ is high and after the $\overline{CS}$ falling edge and until the MSB (D15) is presented. The output format is MSB (D15) first.  |  |
|          |          |          |                 | When FS is not used (FS = 1 at the falling edge of $\overline{CS}$ ), the MSB (D15) is presented to the SDO pin after the $\overline{CS}$ falling edge, and successive data are available at the rising edge of SCLK.   |  |
|          |          |          |                 | When FS is used (FS = 0 at the falling edge of $\overline{CS}$ ), the MSB (D15) is presented to SDO after the falling edge of $\overline{CS}$ and $FS = 0$ is detected. Successive data are available at the falling edge of SCLK (This is typically used with an active FS from a DSP.)                  |  |
|          |          |          |                 | For conversion and FIFO read cycles, the first 12 bits are result from previous conversion (data) followed by 4 don't care bits. The first four bits from SDO for CFR read cycles should be ignored. The register content is in the last 12 bits. SDO is 3-state (float) after the 16th bit.              |  |
| REFM     | 14       | 18       | I               | External reference input or internal reference decoupling.  |  |
| REFP     | 15       | 19       | I               | External reference input or internal reference decoupling. (Shunt capacitors of 10 $\mu$ F and 0.1 $\mu$ F between REFP and REFM.) The maximum input voltage range is determined by the difference between the voltage applied to this terminal and the REFM terminal when an external reference is used. |  |
| VCC      | 5        | 5        | I               | Positive supply voltage   |  |

#### detailed description

#### analog inputs and internal test voltages

The 4/8 analog inputs and three internal test inputs are selected by the analog multiplexer depending on the command entered. The input multiplexer is a break-before-make type to reduce input-to-input noise injection resulting from channel switching.

#### converter

The TLV2544/48 uses a 12-bit successive approximation ADC utilizing a charge redistribution DAC. Figure 1 shows a simplified version of the ADC.

The sampling capacitor acquires the signal on Ain during the sampling period. When the conversion process starts, the SAR control logic and charge redistribution DAC are used to add and subtract fixed amounts of charge from the sampling capacitor to bring the comparator into a balanced condition. When the comparator is balanced, the conversion is complete and the ADC output code is generated.

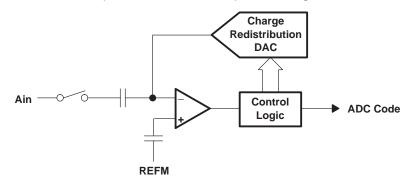


Figure 1. Simplified Model of the Successive-Approximation System



#### detailed description (continued)

#### serial interface

| INPUT DATA FORMAT |                          |  |  |
|-------------------|--------------------------|--|--|
| MSB LSE           |                          |  |  |
| D15–D12           | D11-D0                   |  |  |
| Command           | Configuration data field |  |  |

Input data is binary. All trailing blanks can be filled with zeros.

| OUTPUT DATA FORMAT READ CFR |        |  |  |
|-----------------------------|--------|--|--|
| MSB LS                      |        |  |  |
| D15–D12                     | D11-D0 |  |  |
| Don't care Register content |        |  |  |

| OUTPUT DATA FORMAT CONVERSION/READ FIFO |            |  |  |  |
|---|------------|--|--|--|
| MSB LS                                  |            |  |  |  |
| D15–D4                                  | D3-D0      |  |  |  |
| Conversion result                       | Don't care |  |  |  |

The output data format is binary (unipolar straight binary).

#### binary

Zero scale code = 000h, Vcode = VREFM Full scale code = FFFh, Vcode = VREFP - 1 LSB

#### control and timing

#### power up and initialization requirements

- Determine processor type by writing A000h to the TLV2544/48 (CS must be toggled)
- Configure the device (CS must make a high-to-low transition, then can be held low if in DSP mode; i.e., active FS.)

The first conversion after power up or resuming from power down is not valid.

#### start of the cycle:

- When FS is not used (FS = 1 at the falling edge of  $\overline{CS}$ ), the falling edge of  $\overline{CS}$  is the start of the cycle.
- When FS is used (FS is an active signal from a DSP), the falling edge of FS is the start of the cycle.

#### first 4-MSBs: the command register (CMR)

The TLV2544/TLV2548 have a 4-bit command set (see Table 1) plus a 12-bit configuration data field. Most of the commands require only the first 4 MSBs, i.e., without the 12-bit data field.

#### NOTE:

The device requires a write CFR (configuration register) with 000h data (write A000h to the serial input) at power up to initialize host select mode.

The valid commands are listed in Table 1.



SDI D(15-12) BINARY TLV2548 COMMAND **TLV2544 COMMAND** 0000b Select analog input channel 0 Select analog input channel 0 0h 0001b 1h Select analog input channel 1 N/A Select analog input channel 2 0010b 2h Select analog input channel 1 3h N/A 0011b Select analog input channel 3 0100b 4h Select analog input channel 4 Select analog input channel 2 Select analog input channel 5 0101b 5h N/A 0110b 6h Select analog input channel 6 Select analog input channel 3 0111b 7h Select analog input channel 7 N/A 1000b 8h SW power down (analog + reference) 1001b Read CFR register data shown as SDO D(11-0) 9h Write CFR followed by 12-bit data, e.g., 0A100h means external reference, 1010b Ah plus data short sampling, SCLK/4, single shot, INT 1011b Select test, voltage = (REFP+REFM)/2 Bh 1100b Ch Select test, voltage = REFM 1101b Dh Select test, voltage = REFP 1110b Eh FIFO read, FIFO contents shown as SDO D(15-4), D(3-0) = 0000 Fh plus data 1111b Reserved

#### Table 1. TLV2544/TLV2548 Command Set

#### configuration

Configuration data is stored in one 12-bit configuration register (CFR) (see Table 2 for CFR bit definitions). Once configured after first power up, the information is retained in the H/W or S/W power down state. When the device is being configured, a write CFR cycle is issued by the host processor. This is a 16-bit write. If the SCLK stops after the first 8 bits are entered, then the next eight bits can be taken after the SCLK is resumed. The status of the CFR can be read with a read CFR command when the device is programmed for one-shot conversion mode (CFR D[6,5] = 00).



#### control and timing (continued)

#### Table 2. TLV2544/TLV2548 Configuration Register (CFR) Bit Definitions

| BIT     | DEFIN   | IITION  |  |  |  |
|---------|---|---|--|--|--|
| D11     | Reference select<br>0: External 1: internal   |   |  |  |  |
| D10     | Internal reference voltage select<br>0: Internal ref = 4 V 1: internal ref = 2 V  |   |  |  |  |
| D9      |   | Sample period select<br>0: Short sampling 12 SCLKs (1x sampling time)<br>1: Long sampling 24 SCLKs (2x sampling time) |  |  |  |
| D(8–7)  | Conversion clock source select<br>00: Conversion clock = internal OSC<br>01: Conversion clock = SCLK<br>10: Conversion clock = SCLK/4<br>11: Conversion clock = SCLK/2  |   |  |  |  |
| D(6,5)  | Conversion mode select<br>00: Single shot mode [FIFO not used, D(1,0) has no effect.]<br>01: Repeat mode<br>10: Sweep mode<br>11: Repeat sweep mode   |   |  |  |  |
| D(4,3)† | TLV2548   | TLV2544   |  |  |  |
|         | Sweep auto sequence select         Sweep auto sequence select           00: 0-1-2-3-4-5-6-7         00: N/A           01: 0-2-4-6-0-2-4-6         01: 0-1-2-3-0-1-2-3           10: 0-0-2-2-4-4-6-6         10: 0-0-1-1-2-2-3-3           11: 0-2-0-2-0-2-0-2         11: 0-1-0-1-0-1 |   |  |  |  |
| D2      | EOC/INT – pin function select<br>0: Pin used as INT<br>1: Pin used as EOC   |   |  |  |  |
| D(1,0)  | FIFO trigger level (sweep sequence length)<br>00: Full (INT generated after FIFO level 7 filled)<br>01: 3/4 (INT generated after FIFO level 5 filled)<br>10: 1/2 (INT generated after FIFO level 3 filled)<br>11: 1/4 (INT generated after FIFO level 1 filled)                       |   |  |  |  |

<sup>†</sup> These bits only take effect in conversion modes 10 and 11.

#### sampling

The sampling period starts after the first 4 input data are shifted in if they are decoded as one of the conversion commands. These are select analog input (channel 0 through 7) and select test (channel 1 through 3).

#### normal sampling

When the converter is using normal sampling, the sampling period is programmable. It can be 12 SCLKs (short sampling) or 24 SCLKs (long sampling). Long sampling helps when SCLK is faster than 10 MHz or when input source resistance is high.



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#### extended sampling

CSTART – An asynchronous (to the SCLK) signal, via dedicated hardware pin, CSTART, can be used in order to have total control of the sampling period and the start of a conversion. This extended sampling is user-defined and is totally independent of SCLK. While  $\overline{CS}$  is high, the falling edge of  $\overline{CSTART}$  is the start of the sampling period and is controlled by the low time of CSTART. The minimum low time for CSTART should be at least equal to the minimum t(SAMPLE). In a select cycle used in mode 01 (REPEAT MODE), CSTART can be started as soon as the channel is selected (after the fifth SCLK). In this case the sampling period is not started until CS has become inactive. Therefore the nonoverlapped CSTART low time must meet the minimum sampling time requirement. The low-to-high transition of CSTART terminates the sampling period and starts the conversion period. The conversion clock can also be configured to use either internal OSC or external SCLK. This function is useful for an application that requires:

- The use of an extended sampling period to accommodate different input source impedance
- The use of a faster I/O clock on the serial port but not enough sampling time is available due to the fixed number of SCLKs. This could be due to a high input source impedance or due to higher MUX ON resistance at lower supply voltage.

Once the conversion is complete, the processor can initiate a read cycle by using either the read FIFO command to read the conversion result or by simply selecting the next channel number for conversion. Since the device has a valid conversion result in the output buffer, the conversion result is simply presented at the serial data output. To completely get out of the extended sampling mode,  $\overline{CS}$  must be toggled twice from a high-to-low transition while CSTART is high. The read cycle mentioned above followed by another configuration cycle of the ADC gualifies this condition and will successfully put the ADC back to its normal sampling mode. This can be viewed in Figure 9.

|               | CONDITIONS                                       | SAMPLE   | CONVERT  |
|---------------|--|--|--|
| CSTART        | CS = 1   | <b>No sampling clock (SCLK) required.</b> Sampling period is totally controlled by the low time of CSTART. The high-to-low transition of CSTART (when CS=1) starts the sampling of the analog input signal. The low time of CSTART dictates the sampling period. The low-to-high transition of CSTART ends sampling period and begins the conversion cycle. (Note: this trigger only works when internal reference is selected for conversion modes 01, 10, and 11.) | 1) If internal clock OSC is selected a minimum of 3 MHz  |
| <del>cs</del> | CSTART = 1<br>FS = 1                             | <b>SCLK is required.</b> Sampling period is programmable<br>under normal sampling. When programmed to sample<br>under short sampling, 12 SCLKs are generated to<br>complete sampling period. 24 SCLKs are generated<br>when programmed for long sampling. A command set<br>to configure the device requires 4 SCLKs thereby ex-  | <ul> <li>(equivalent to 4.6 μs conversion speed) can be achieved.</li> <li>2) If external SCLK is selected, conversion time is t<sub>CONV</sub> = 14 × DIV/f<sub>(SCLK)</sub>, where DIV can be 1, 2, or 4.</li> </ul> |
| FS            | $\overline{\frac{\text{CSTART}}{\text{CS}}} = 1$ | tending to 16 or 28 SCLKs respectively before conver-<br>sion takes place. (Note: Because the ADC only<br>bypasses a valid channel select command, the user<br>can use select channel 0, 0000b, as the SDI input<br>when either CS or FS is used as trigger for conversion.<br>The ADC responds to commands such as SW power-<br>down, 1000b.)   |  |

#### **Table 3. Sample and Convert Conditions**



#### TLV2544/TLV2548 conversion modes

The TLV2544 and TLV2548 have four different conversion modes (mode 00, 01, 10, 11). The operation of each mode is slightly different, depending on how the converter performs the sampling and which host interface is used. The trigger for a conversion can be an active  $\overline{CSTART}$  (extended sampling),  $\overline{CS}$  (normal sampling, SPI interface), or FS (normal sampling, TMS320 DSP interface). When FS is used as the trigger,  $\overline{CS}$  can be held active, i.e.  $\overline{CS}$  does not need to be toggled through the trigger sequence. SDI can be one of the channel select commands, such as SELECT CHANNEL 0. Different types of triggers should not be mixed throughout the repeat and sweep operations. When  $\overline{CSTART}$  is used as the trigger, the conversion starts on the rising edge of  $\overline{CSTART}$ . The minimum low time for  $\overline{CSTART}$  is equal to  $t_{(SAMPLE)}$ . If an active  $\overline{CS}$  or FS is used as the trigger, the conversion) should be allowed between consecutive triggers so that no conversion is terminated prematurely.

#### one shot mode (mode 00)

One shot mode (mode 00) does not use the FIFO, and the EOC is generated as the conversion is in progress (or INT is generated after the conversion is done).

#### repeat mode (mode 01)

Repeat mode (mode 01) uses the FIFO. This mode setup requires configuration cycle and channel select cycle. Once the programmed FIFO threshold is reached, the FIFO must be read, or the data is lost when the sequence starts over again with the SELECT cycle and series of triggers. No configuration is required except for reselecting the channel unless the operation mode is changed. This allows the host to set up the converter and continue monitoring a fixed input and come back to get a set of samples when preferred.

Triggered by  $\overline{\text{CSTART}}$ : The first conversion can be started with a select cycle or  $\overline{\text{CSTART}}$ . To do so, the user can issue  $\overline{\text{CSTART}}$  during the select cycle, immediately after the four-bit channel select command. The first sample started as soon as the select cycle is finished (i.e.,  $\overline{\text{CS}}$  returns to 1). If there is enough time (2 µs) left between the SELECT cycle and the following  $\overline{\text{CSTART}}$ , a conversion is carried out. In this case, you will need one less trigger to fill the FIFO. Succeeding samples are triggered by  $\overline{\text{CSTART}}$ .

#### sweep mode (mode 10)

Sweep mode (mode 10) also uses the FIFO. Once it is programmed in this mode, all of the channels listed in the selected sweep sequence are visited in sequence. The results are converted and stored in the FIFO. This sweep sequence may not be completed if the FIFO threshold is reached before the list is completed. This allows the system designer to change the sweep sequence length. Once the FIFO has reached its programmed threshold, an interrupt (INT) is generated. The host must issue a read FIFO command to read and clear the FIFO before the next sweep can start.

#### repeat sweep mode (mode 11)

Repeat sweep mode (mode 11) works the same way as mode 10 except the operation has an option to continue even if the FIFO threshold is reached. Once the FIFO has reached its programmed threshold, an interrupt (INT) is generated. Then two things may happen:

- 1. The host may choose to act on it (read the FIFO) or ignore it. If the next cycle is a read FIFO cycle, all of the data stored in the FIFO is retained until it has been read in order.
- 2. If the next cycle is not a read FIFO cycle, or another CSTART is generated, all of the content stored in the FIFO is cleared before the next conversion result is stored in the FIFO, and the sweep is continued.



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#### TLV2544/TLV2548 conversion modes (continued)

| CONVERSION<br>MODE   | CFR<br>D(6,5) | SAMPLING<br>TYPE   | OPERATION  |
|--|---------------|--|--|
| One shot   | 00            | Normal   | <ul> <li>Single conversion from a selected channel</li> <li>CS or FS to start select/sampling/conversion/read</li> <li>One INT or EOC generated after each conversion</li> <li>Host must serve INT by selecting channel, and converting and reading the previous output.</li> </ul>  |
|  |               | Extended   | <ul> <li>Single conversion from a selected channel</li> <li><u>CS to select/read</u></li> <li><u>CSTART</u> to start sampling and conversion</li> <li>One INT or EOC generated after each conversion</li> <li>Host must serve INT by selecting next channel and reading the previous output.</li> </ul>  |
| Repeat   | 01            | Normal   | <ul> <li>Repeated conversions from a selected channel</li> <li>CS or FS to start sampling/conversion</li> <li>One INT generated after FIFO is filled up to the threshold</li> <li>Host must serve INT by either 1) (FIFO read) reading out all of the FIFO contents up to the threshold, then repeat conversions from the same selected channel or 2) writing another command(s) to change the conversion mode. If the FIFO is not read when INT is served, it is cleared.</li> </ul>    |
|  |               | Extended   | <ul> <li>Same as normal sampling except CSTART starts each sampling and conversion when CS is<br/>high.</li> </ul>   |
| <ul> <li>CS or FS to start sampling/conversion</li> <li>One INT generated after FIFO is filled up to the thr</li> <li>Host must serve INT by (FIFO read) reading out all of</li> </ul> |               | <ul> <li>One conversion per channel from a sequence of channels</li> <li>CS or FS to start sampling/conversion</li> <li>One INT generated after FIFO is filled up to the threshold</li> <li>Host must serve INT by (FIFO read) reading out all of the FIFO contents up to the threshold, then write another command(s) to change the conversion mode.</li> </ul> |  |
|  |               | Extended   | <ul> <li>Same as normal sampling except CSTART starts each sampling and conversion when CS is<br/>high.</li> </ul>   |
| Repeat sweep   | 11            | Normal   | <ul> <li>Repeated conversions from a sequence of channels</li> <li>CS or FS to start sampling/conversion</li> <li>One INT generated after FIFO is filled up to the threshold</li> <li>Host must serve INT by either 1) (FIFO read) reading out all of the FIFO contents up to the threshold, then repeat conversions from the same selected channel or 2) writing another command(s) to change the conversion mode. If the FIFO is not read when INT is served it is cleared.</li> </ul> |
|  |               | Extended   | <ul> <li>Same as normal sampling except CSTART starts each sampling and conversion when CS is<br/>high.</li> </ul>   |

#### Table 4. TLV2544/TLV2548 Conversion Mode

NOTES: 1. Programming the EOC/INT pin as the EOC signal works for mode 00 only. The other three modes automatically generate an INT signal irrespective of how EOC/INT is programmed.

2. When using CSTART to sample in extended mode, the falling edge of the next CSTART trigger should occur no more than 2.5 µs after the falling CS edge (or falling FS edge if FS is active) of the channel select cycle. This is to prevent an ongoing conversion from being canceled.



#### timing diagrams

The timing diagrams can be categorized into two major groups: nonconversion and conversion. The nonconversion cycles are read and write (configuration). None of these cycles carry a conversion. Conversion cycles are those four modes of conversion.

#### read cycle (read FIFO or read CFR)

#### read CFR cycle:

The read command is decoded in the first 4 clocks. SDO outputs the contents of the CFR after the 4th SCLK.

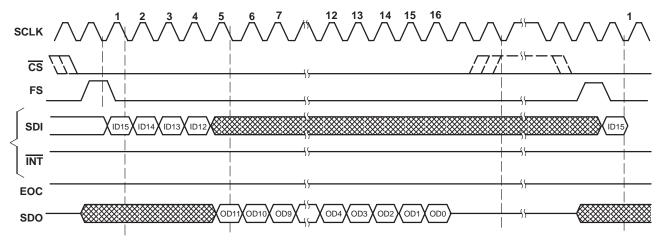


Figure 2. TLV2544/TLV2548 Read CFR Cycle (FS active)

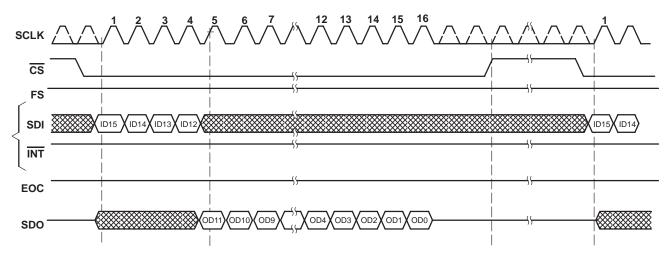


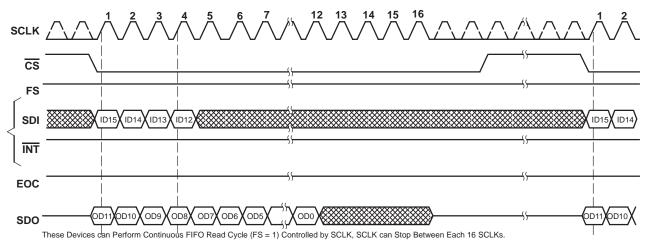
Figure 3. TLV2544/TLV2548 Read CFR Cycle (FS = 1)



#### read cycle (read FIFO or read CFR) (continued)

#### FIFO read cycle

The first command in the active cycle after INT is generated, if the FIFO is used, is assumed as the FIFO read command. The first FIFO content is output immediately before the command is decoded. If this command is not a FIFO read, then the output is terminated but the first data in the FIFO is retained until a valid FIFO read command is decoded. Use of more layers of the FIFO reduces the time taken to read multiple data. This is because the read cycle does not generate EOC or INT, nor does it carry out any conversion.







#### write cycle (write CFR)

The write cycle is used to write to the configuration register CFR (with 12-bit register content). The write cycle does not generate an EOC or  $\overline{INT}$ , nor does it carry out any conversion (see power up and initialization requirements).

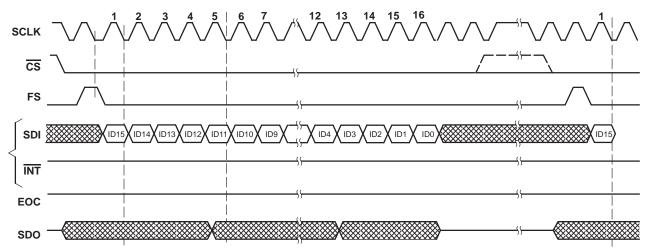


Figure 5. TLV2544/TLV2548 Write Cycle (FS Active)

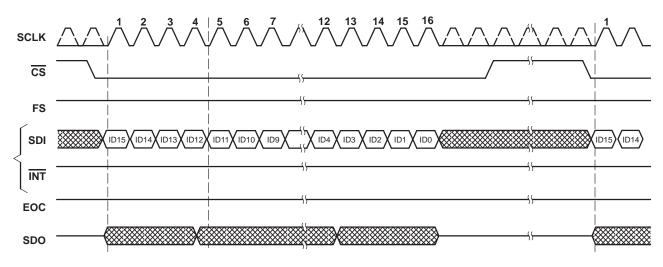
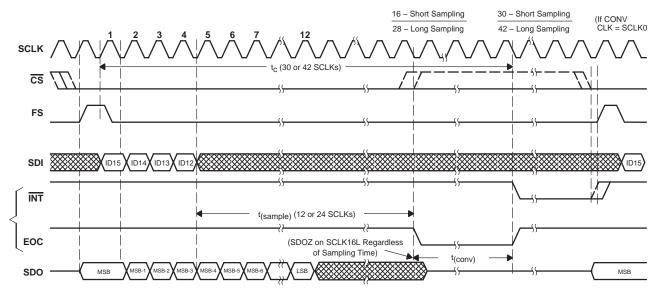


Figure 6. TLV2544/TLV2548 Write Cycle (FS = 1)



#### conversion cycles

#### **DSP/normal sampling**





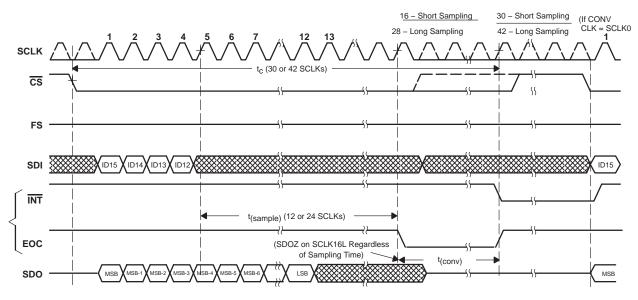
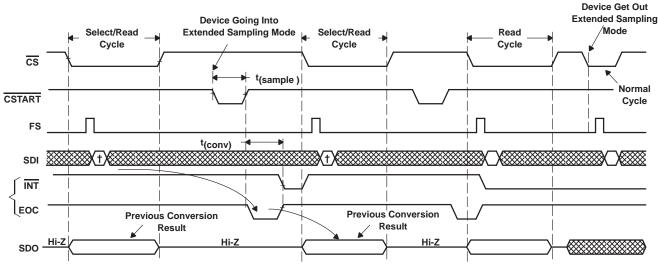


Figure 8. Mode 00 Single Shot/Normal Sampling (FS = 1, FS Signal not Used)

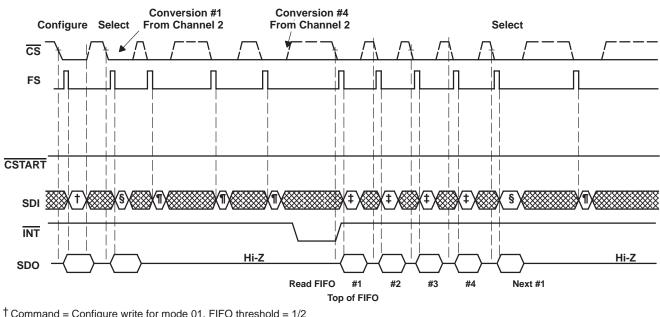


#### conversion cycles (continued)



<sup>†</sup> This is one of the single shot commands. Conversion starts on next rising edge of CSTART.

#### Figure 9. Mode 00 Single Shot/Extended Sampling (FS Signal Used, FS Pin Connected to TMS320 DSP)



#### modes using the FIFO: modes 01, 10, 11 timing

<sup>†</sup> Command = Configure write for mode 01, FIFO threshold = 1/2

<sup>‡</sup>Command = Read FIFO, 1st FIFO read

§ Command = Select ch2.

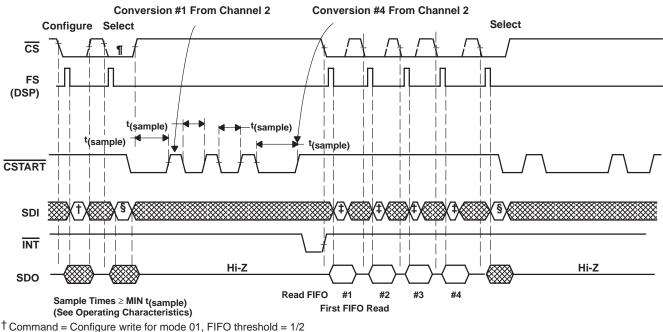
¶ Use any channel select command to trigger SDI input.

Figure 10. TLV2544/TLV2548 Mode 01 DSP Serial Interface (Conversions Triggered by FS)



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### modes using the FIFO: modes 01, 10, 11 timing (continued)

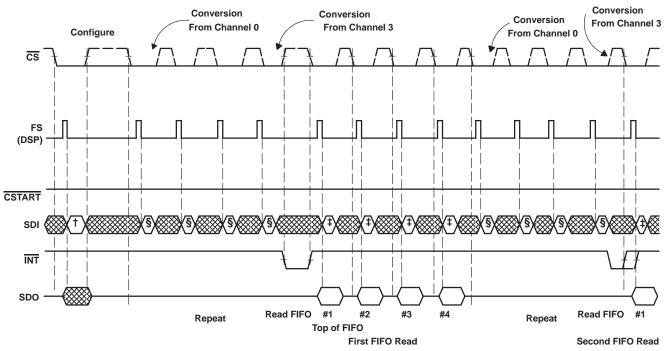


‡ Command = Read FIFO, 1st FIFO read

§ Command = Select ch2.

¶ Minimum CS low time for select cycle is 6 SCLKs. The same amount of time is required between FS low to CSTART for proper channel decoding. The low time of CSTART, not overlapped with CS low time, is the valid sampling time for the select cycle (see Figure 18).

#### Figure 11. TLV2544/TLV2548 Mode 01 μp/DSP Serial Interface (Conversions Triggered by CSTART)



<sup>†</sup> Command = Configure write for mode 10 or 11, FIFO threshold = 1/2, sweep seq = 0-1-2-3.

‡ Command = Read FIFO

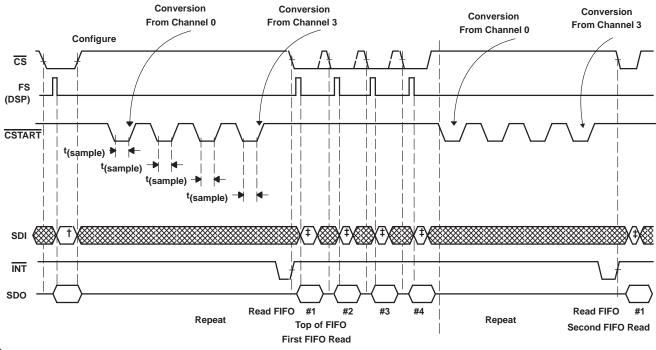
§ Use any channel select command to trigger SDI input.

#### Figure 12. TLV2544/TLV2548 Mode 10/11 DSP Serial Interface (Conversions Triggered by FS)



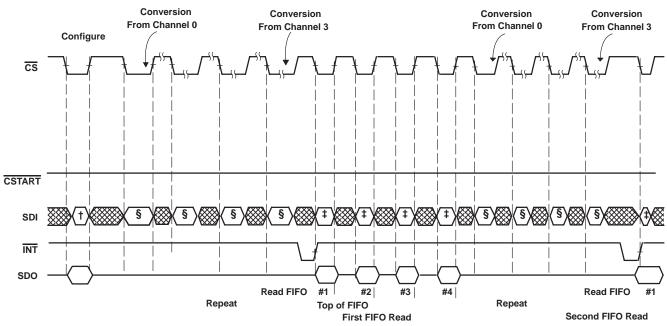
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#### modes using the FIFO: modes 01, 10, 11 timing (continued)



<sup>&</sup>lt;sup>†</sup> Command = Configure write for mode 10 or 11, FIFO threshold = 1/2, sweep seq = 0-1-2-3. ‡Command = Read FIFO

#### Figure 13. TLV2544/TLV2548 Mode 10/11 DSP Serial Interface (Conversions Triggered by CSTART)



<sup>†</sup> Command = Configure write for mode 10 or 11, FIFO threshold = 1/2, sweep seq = 0-1-2-3.

<sup>‡</sup>Command = Read FIFO

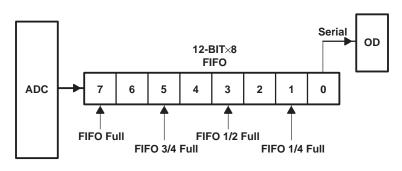
§ Use any channel select command to trigger SDI input.

Figure 14. TLV2544/TLV2548 Mode 10/11  $\mu$ p Serial Interface (Conversions Triggered by  $\overline{CS}$ )



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#### **FIFO** operation



**FIFO Threshold Pointer** 

#### Figure 15. TLV2544/TLV2548 FIFO

The device has an 8-layer FIFO that can be programmed for different thresholds. An interrupt is sent to the host after the preprogrammed threshold is reached. The FIFO can be used to store data from either a fixed channel or a series of channels based on a preprogrammed sweep sequence. For example, an application may require eight measurements from channel 3. In this case, the FIFO is filled with eight data sequentially taken from channel 3. Another application may require data from channel 0, channel 2, channel 4, and channel 6 in an orderly manner. Therefore, the threshold is set for 1/2 and the sweep sequence 0-2-4-6-0-2-4-6 is chosen. An interrupt is sent to the host as soon as all four data are in the FIFO.

In single shot mode, the FIFO automatically uses a 1/8 FIFO depth. Therefore the CFR bits (D1,0) controlling FIFO depth are don't care.

#### SCLK and conversion speed

There are two ways to adjust the conversion speed.

The SCLK can be used as the source of the conversion clock.

The onboard OSC is approximately 4 MHz and 14 conversion clocks are required to complete a conversion. (Corresponding 3.5 µs conversion time) The devices can operate with an SCLK up to 20 MHz for the supply voltage range specified. When a more accurate conversion time is desired, the SCLK can be used as the source of the conversion clock. The clock divider provides speed options appropriate for an application where a high speed SCLK is used for faster I/O. The total conversion time is  $14 \times (DIV/f_{SCLK})$  where DIV is 1, 2, or 4. For example a 20 MHz SCLK with the divide by 4 option produces a  $\{14 \times (4/20 \text{ M})\} = 2.8 \ \mu\text{s}$ conversion time. When an external serial clock (SCLK) is used as the source of the conversion clock, the maximum equivalent conversion clock (f<sub>SCLK</sub>/DIV) should not exceed 6 MHz.

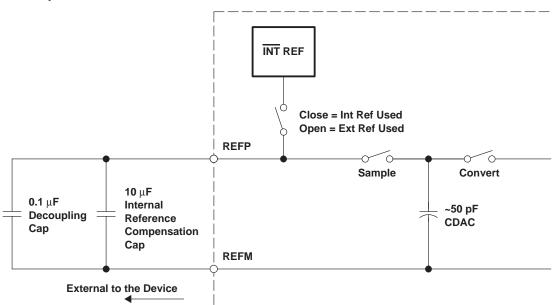
Autopower down can be used. This mode is always on. If the device is not accessed (by  $\overline{CS}$  or  $\overline{CSTART}$ ), the converter is powered down to save power. The built-in reference is left on in order to quickly resume operation within one half SCLK period. This provides unlimited choices to trade speed with power savings.

#### reference voltage

The device has a built-in reference with a programmable level of 2 V or 4 V. If the internal reference is used, REFP is set to 2 V or 4 V and REFM is set to 0 V. An external reference can also be used through two reference input pins, REFP and REFM, if the reference source is programmed as external. The voltage levels applied to these pins establish the upper and lower limits of the analog inputs to produce a full-scale and zero-scale reading respectively. The values of REFP, REFM, and the analog input should not exceed the positive supply or be lower than GND consistent with the specified absolute maximum ratings. The digital output is at full scale when the input signal is equal to or higher than REFP and at zero when the input signal is equal to or lower than REFM.



reference block equivalent circuit



- NOTES: A. If internal reference is used, tie REFM to AGND and install a 10  $\mu$ F (or 4.7  $\mu$ F) internal reference compensation capacitor between REFP and REFM to store the charge as shown in the figure above.
  - B. If external reference is used, the 10 μF (internal reference compensation) capacitor is optional. REFM can be connected to external REFM or AGND.
  - C. Internal reference voltage drift, due to temperature variations, is approximately ±10 mV about the nominal 2 V (typically) from -10°C to 100°C. The nominal value also varies approximately ±50 mV across devices.
  - D. Internal reference leakage during low ON time: Leakage resistance is on the order of 100 M $\Omega$  or more. This means the time constant is about 1000 s with 10  $\mu$ F compensation capacitance. Since the REF voltage does not vary much, the reference will come up quickly after resuming from auto power down. At power up and power down the internal reference sees a glitch of about 500  $\mu$ V when 2 V internal reference is used (1 mV when 4 V internal reference is used). This glitch settles out after about 50  $\mu$ s.

#### power down

Writing 8000h to the device puts the device into a software power down state. For a hardware power-down, the dedicated PWDN pin provides another way to power down the device asynchronously. These two power-down modes power down the entire device including the built-in reference to save power. It requires 20 ms to resume from either a software or hardware power down.

Auto power-down mode is always enabled. This mode maintains the built-in reference if an internal reference is used so resumption is fast enough to be used between cycles.

The configuration register is not affected by any of the power down modes but the sweep operation sequence has to be started over again. All FIFO contents are cleared by the power-down modes.



absolute maximum ratings over operating free-air temperature (unless otherwise noted)<sup>†</sup>

| Supply voltage range, GND to $V_{CC}$<br>Analog input voltage range<br>Reference input voltage<br>Digital input voltage range<br>Operating virtual junction temperature range, $T_J$<br>Operating free-air temperature range, $T_A$ : TLV2544/48Q<br>TLV2548M | $\begin{array}{cccc} -0.3 \ V \ to \ V_{CC} + 0.3 \ V \\ & & & V_{CC} + 0.3 \ V \\ & & & & -0.3 \ V \ to \ V_{CC} + 0.3 \ V \\ & & & & -55^\circ C \ to \ 150^\circ C \end{array}$ |
|---|--|
| Storage temperature range, T <sub>stg</sub><br>Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds   |  |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

| DISSIPATION RATING TABLE                                 |         |            |        |        |        |  |  |
|--|---------|------------|--------|--------|--------|--|--|
| $\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$ |         |            |        |        |        |  |  |
| D  | 1110 mW | 8.9 mW/°C  | 710 mW | 577 mW | 222 mW |  |  |
| DW   | 1294 mW | 10.4 mW/°C | 828 mW | 673 mW | 259 mW |  |  |
| FK   | 1375 mW | 11.0 mW/°C | 880 mW | 715 mW | 275 mW |  |  |

<sup>‡</sup> This is the inverse of the traditional junction-to-ambient thermal resistance (R<sub>OJA</sub>). Thermal resistance is not production tested and the values given are for informational purposes only.



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#### recommended operating conditions

|  |   |                                    | MIN                     | NOM              | MAX              | UNIT |
|--|---|------------------------------------|-------------------------|------------------|------------------|------|
| Supply voltage, V <sub>CC</sub>  |   |                                    | 3                       | 3.3              | 5.5              | V    |
| Analog input voltage (see Note 3)  |   |                                    | 0                       |                  | VCC              | V    |
| High level control input voltage, VIH  |   |                                    | 2.1                     |                  |                  | V    |
| Low-level control input voltage, VIL   |   |                                    |                         |                  | 0.6              | V    |
| Setup time, t <sub>su(CS-SCLK)</sub> CS falling edge before<br>SCLK rising edge (FS=1) or before SCLK falling      |   | SCLK = 20 MHz                      | 20                      |                  |                  | ns   |
| edge (when FS is active)   | $V_{CC} = 3 V, SC$                      | LK = 20 MHz                        | 30                      |                  |                  |      |
| Hold time, CS rising edge after SCLK rising edge (FS=1) or after SCLK falling edge (when FS is                     | V <sub>CC</sub> = 4.5 V                 |                                    | 10                      |                  |                  | ns   |
| active), th(SCLK-CS)   | $V_{CC} = 3 V$                          |                                    | 15                      |                  |                  |      |
| Delay time, delay from CS falling edge to FS rising e  | edge, t <sub>d(CSL-FSI</sub>            | H)                                 | 0.5                     |                  |                  | SCLK |
| Delay time, delay time from 16th SCLK falling edge <sup>t</sup> d(SCLK16L-CSH)                                     | to CS rising edge                       | e (FS is active),                  | 0.5                     |                  |                  | SCLK |
| Setup time, FS rising edge before SCLK falling edge  | <sup>e, t</sup> su(FSH-SCLK             | L)                                 | 20                      |                  |                  | ns   |
| Hold time, FS hold high after SCLK falling edge, t <sub>h(l</sub>  |   |                                    | 30                      |                  | 37               | ns   |
| Pulse width, CS high time, twH(CS)   | ,                                       |                                    | 100                     |                  |                  | ns   |
| Pulse width, FS high time, t <sub>WH</sub> (FS)  |   |                                    | 0.75                    |                  | 1                | SCLK |
| SCLK cycle time, $V_{CC} = 3 V$ to 3.6V, $t_{c(SCLK)}$   |   |                                    | 67                      |                  | 10000            | ns   |
| SCLK cycle time, $V_{CC} = 4.5 V$ to 5.5V, $t_{C(SCLK)}$   |   |                                    | 50                      |                  | 10000            | ns   |
|  |   | V <sub>CC</sub> = 4.5 V            | 22                      |                  |                  |      |
| Pulse width, SCLK low time, $t_{WL}(SCLK)$   |   | V <sub>CC</sub> = 3 V              | 27                      |                  |                  | ns   |
| Dulas width CCLK high time to use a up   | V <sub>CC</sub> = 4.5 V                 | 22                                 |                         |                  |                  |      |
| Pulse width, SCLK high time, twH(SCLK)   | $V_{CC} = 3 V$                          | 27                                 |                         |                  | ns               |      |
| Setup time, SDI valid before falling edge of SCLK (F<br>SCLK (FS=1), t <sub>SU</sub> (DI-SCLK)                     | S is active) or the                     | e rising edge of                   | 25                      |                  |                  | ns   |
| Hold time, SDI hold valid after falling edge of SCLK of SCLK (FS=1), $t_h(DI-SCLK)$                                | (FS is active) or t                     | the rising edge                    | 5                       |                  |                  | ns   |
| Delay time, delay from CS falling edge to SDO valid  | <sup>l, t</sup> d(CSL-DOV)              |                                    |                         |                  | 25               | ns   |
| Delay time, delay from FS falling edge to SDO valid  | , td(FSL-DOV)                           |                                    |                         |                  | 25               | ns   |
|  |   | SDO = 0 pF                         |                         | 0.5 SCLK<br>+ 5  |                  |      |
| Delay time, delay from SCLK falling edge (FS is  | V <sub>CC</sub> = 5.5 V                 | SDO = 60 pF                        |                         |                  | 0.5 SCLK<br>+ 24 |      |
| active) or SCLK rising edge (FS=1) to SDO valid,<br><sup>t</sup> d(SCLK-DOV)                                       |   | SDO = 0 pF                         |                         | 0.5 SCLK<br>+ 12 |                  | ns   |
|  | V <sub>CC</sub> = 3.3 V                 | SDO = 60 pF                        |                         |                  | 0.5 SCLK<br>+ 33 |      |
| Delay time, delay from CS rising edge to SDO 3-sta   | te, td(CSH-DOZ)                         | •                                  |                         | 80               |                  | ns   |
| Delay time, delay from 17th SCLK rising edge (FS is (FS=1) to EOC falling edge, td(SCLK-EOCL)                      |   | 45                                 |                         | ns               |                  |      |
| Delay time, delay from 16 <u>th S</u> CLK falling edge to IN<br>17th rising edge SCLK to INT falling edge (when FS | T falling edge (FS<br>active), td(SCI k | S <u>=1)</u> or from the<br>(-INT) | Min t <sub>(conv)</sub> |                  |                  | μs   |
| Delay time, delay from CS falling edge to INT rising   | (                                       | /                                  |                         |                  | 50               | ns   |
| Delay time, delay from CS rising edge to CSTART fa   |   |                                    | 100                     |                  |                  | ns   |
| Delay time, delay from CSTART rising edge to EOC   |   |                                    |                         |                  | 50               | ns   |
|  |   | <u> </u>                           | 1                       |                  | _                |      |

NOTE 3: When binary output format is used, analog input voltages greater than that applied to REFP convert as all ones (1111111111), while input voltages less than that applied to REFM convert as all zeros (00000000000). The device is functional with reference down to 1 V. (VREFP - VREFM - 1); however, the electrical specifications are no longer applicable.



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#### recommended operating conditions (continued)

|  |                         | MIN                     | NOM | MAX | UNIT |  |
|--|-------------------------|-------------------------|-----|-----|------|--|
| Delay time, delay from CSTART rising edge to CSTA<br><sup>t</sup> d(CSTARTH-CSTARTL) | Max t <sub>(conv)</sub> |                         |     | μs  |      |  |
| Delay time, delay from CSTART rising edge to INT fa                                  |                         | Max t <sub>(conv)</sub> |     | μs  |      |  |
|  | TLV2544Q/TLV2548Q       | -40                     |     | 125 |      |  |
| Operating free-air temperature, T <sub>A</sub>                                       | TLV2548M                | -55                     |     | 125 | °C   |  |

# electrical characteristics over recommended operating free-air temperature range, $V_{CC} = V_{REFP} = 3 V$ to 5.5 V, SCLK frequency = 20 MHz at 5 V, 15 MHz at 3 V (unless otherwise noted)

|                     | PARAMETER  | TEST C   | ONDITIONS   | MIN                  | TYP <sup>†</sup> | MAX | UNIT |  |
|---------------------|--|--|---|----------------------|------------------|-----|------|--|
|                     |  | V <sub>CC</sub> = 5.5 V, I <sub>OH</sub> = -         | 0.2 mA at 30 pF load  | 2.4                  |                  |     |      |  |
| V <sub>OH</sub>     | High-level output voltage  | V <sub>CC</sub> = 3 V, I <sub>OH</sub> = -20         | μA at 30 pF load  | V <sub>CC</sub> -0.2 |                  |     | V    |  |
|                     |  | $V_{CC} = 5.5 \text{ V}, \ I_{OL} = 0.5 \text{ V}$   | 8 mA at 30 pF load  |                      |                  | 0.4 | V    |  |
| V <sub>OL</sub>     | Low-level output voltage   | $V_{CC} = 3 V, I_{OL} = 20$                          | $V_{CC} = 3 \text{ V}, \text{ I}_{OL} = 20 \mu\text{A} \text{ at } 30 p\text{F} \text{ load}$ |                      |                  | 0.1 |      |  |
| I <sub>OZ</sub>     | Off-state output current<br>(high-impedance-state)   | $V_{O} = V_{CC}$                                     | $\overline{\text{CS}} = \text{V}_{\text{CC}}$   |                      | 1                | 2.5 | μΑ   |  |
| I <sub>OZ</sub>     | Off-state output current<br>(high-impedance-state)   | $V_{O} = 0$  | $\overline{\text{CS}} = \text{V}_{\text{CC}}$   | -2.5                 | -1               |     | μΑ   |  |
| Іін                 | High-level input current   | V <sub>I</sub> = V <sub>CC</sub>                     |   |                      | 0.005            | 2.5 | μA   |  |
| IIL                 | Low-level input current  | $V_{I} = 0 V$  |   |                      | -0.005           | 2.5 | μΑ   |  |
|                     |  |  | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$  |                      |                  | 2   |      |  |
|                     | Operating supply current, normal   | CS at 0 V, Ext ref                                   | $V_{CC} = 3 V \text{ to } 3.3 V$  |                      |                  | 1   | mA   |  |
|                     | sampling (short)   |  | V <sub>CC</sub> = 4.5 V to 5.5 V  |                      |                  | 2.4 |      |  |
|                     |  | CS at 0 V, Int ref                                   | V <sub>CC</sub> = 3 V to 3.3 V  |                      |                  | 1.7 | mA   |  |
| I <sub>CC</sub>     |  |  | V <sub>CC</sub> = 4.5 V to 5.5 V  |                      | 1.1              |     | m^   |  |
|                     | Operating supply current, extended   | CS at 0 V, Ext ref                                   | $V_{CC} = 3 V \text{ to } 3.3 V$  |                      | 1                |     | mA   |  |
|                     | sampling   | CS at 0 V Int raf                                    | V <sub>CC</sub> = 4.5 V to 5.5 V  |                      | 2.1              |     |      |  |
|                     |  | CS at 0 V, Int ref                                   | $V_{CC} = 3 V \text{ to } 3.3 V$  |                      | 1.7              |     | mA   |  |
|                     |  | $\overline{\text{CS}}$ at 0 V, $V_{\text{CC}} = 4$ . |   | 1                    |                  |     |      |  |
|                     | Internal reference supply current  | $V_{CC}$ = 3 V to 3.3 V                              |   |                      |                  | 0.7 | mA   |  |
|                     | Power down supply current for all digital inputs,  | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$          | 1   |                      |                  |     |      |  |
| I <sub>CC(PD)</sub> | $\begin{array}{l} 0 \leq V_{I} \leq 0.3 \text{ V or} \\ V_{I} \geq V_{CC} - 0.3 \text{ V},  \text{SCLK} = 0 \end{array}$ | $V_{CC} = 3 V \text{ to } 3.3 V, E$                  |   |                      | μA               |     |      |  |
|                     | Auto power-down current for all  | $V_{CC} = 4.5 \text{ V to 5.5 V},$                   | Ext clock, Ext ref  |                      | 1‡               |     | 1    |  |
| CC(AUTOPWDN)        | digital inputs, $0 \le V_1 \le 0.3 \text{ V}$ or $V_1 \ge V_{CC} - 0.3 \text{ V}$ , SCLK = 0                             | V <sub>CC</sub> = 3 V to 3.3 V, I                    | 1§  |                      |                  | μA  |      |  |
|                     |  | Selected channel at                                  |   |                      |                  | 2.5 |      |  |
|                     | Selected channel leakage current   | Selected channel at                                  |   |                      |                  | 2.5 | μA   |  |
|                     | Maximum EXT analog reference<br>current into REFP (use external<br>reference)  |  | $V_{\text{REFP}} = V_{\text{CC}} = 5.5 \text{ V}, V_{\text{REFM}} = \text{GND}$               |                      |                  | 20  | μA   |  |
| -                   |  | Analog inputs  |   |                      | 45               | 50  | _    |  |
| Ci                  | Input capacitance  | Control Inputs                                       |   | 5                    | 25               | pF  |      |  |
| _                   |  | V <sub>CC</sub> = 4.5 V                              |   |                      | 500              |     |      |  |
| Zi                  | Input MUX ON resistance  | V <sub>CC</sub> = 3 V                                | 600   |                      |                  | Ω   |      |  |

<sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

 $\pm$  1.2 mA typical if internal reference is used, 165  $\mu$ A typical if internal clock is used.

0.8 mA typical if internal reference is used, 116  $\mu$ A typical if internal clock is used.



# electrical characteristics over recommended operating free-air temperature range, $V_{CC} = V_{REFP} =$ 3 V to 5.5 V, SCLK frequency = 20 MHz at 5 V, 15 MHz at 3 V (unless otherwise noted) (continued)

#### ac specifications

|                               | PARAMETER                           | TEST C                              | ONDITIONS                           | MIN     | TYP | MAX  | UNIT |
|-------------------------------|-------------------------------------|-------------------------------------|-------------------------------------|---------|-----|------|------|
| SINAD                         | Signal-to-noise ratio +distortion   | f <sub>I</sub> = 12 kHz at 200 KSPS |                                     | 65      | 71  |      | dB   |
| -                             |                                     | ( (0)))) (0)00) (0)D0               | $T_A = -55^{\circ}C$                | -82 -73 |     | -73  | 15   |
| THD Total harmonic distortion | f <sub>I</sub> = 12 kHz at 200 KSPS | All other temperatures              |                                     | -82     | -75 | dB   |      |
| ENOB                          | Effective number of bits            | fj = 12 kHz at 200 KSPS             |                                     | 11.6    |     | Bits |      |
| SFDR                          | Spurious free dynamic range         | f <sub>I</sub> = 12 kHz at 200 KSPS | f <sub>I</sub> = 12 kHz at 200 KSPS |         |     |      | dB   |
| Analog                        | input                               |                                     |                                     |         |     |      |      |
|                               | Full power-bandwidth, -3 dB         |                                     |                                     |         | 1   |      | MHz  |
|                               | Full-power bandwidth, -1 dB         |                                     |                                     |         | 500 |      | kHz  |

#### reference specifications (0.1 $\mu$ F and 10 $\mu$ F between REFP and REFM pins)

| PARAMETER                                       | TE                                      | ST CONDITIONS                | MIN   | TYP | MAX    | UNIT |
|---|---|------------------------------|-------|-----|--------|------|
| Positive reference input voltage, REFP          | V <sub>CC</sub> = 3 V to 5.5 \          | /                            | 2     |     | VCC    | V    |
| Negative reference input voltage, REFM          | V <sub>CC</sub> = 3 V to 5.5 \          | /                            | 0     |     | 2      | V    |
|   |   | CS = 1, $SCLK = 0$ , (off)   | 100   |     |        | MΩ   |
| Reference Input impedance                       | V <sub>CC</sub> = 5.5 V                 | CS = 0, $SCLK = 20$ MHz (on) | 20    | 25  |        | kΩ   |
|   | V <sub>CC</sub> = 3 V                   | CS = 1, $SCLK = 0$ (off)     | 100   |     |        | MΩ   |
|   |   | CS = 0, $SCLK = 20$ MHz (on) | 20    | 25  |        | kΩ   |
| Reference Input voltage difference, REFP – REFM | $V_{CC} = 3 V \text{ to } 5.5 V$        | /                            | 2     |     | VCC    | V    |
|   | V <sub>CC</sub> = 5.5 V                 | VREF SELECT = 4 V            | 3.85  | 4   | 4.15   | V    |
| Internal reference voltage, REFP – REFM         | V <sub>CC</sub> = 5.5 V                 | VREF SELECT = 2 V            | 1.925 | 2   | 2.075  | V    |
|   | V <sub>CC</sub> = 3 V VREF SELECT = 2 V |                              |       | 2   | 2.075  | V    |
| Internal reference start-up time                | $V_{CC} = 5.5 V, 3 V v$                 |                              | 20    |     | ms     |      |
| Internal reference temperature coefficient      | $V_{CC} = 3 V \text{ to } 5.5 V$        |                              | 16    | 40† | PPM/°C |      |

<sup>†</sup>Not assured



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# operating characteristics over recommended operating free-air temperature range, $V_{CC} = V_{REFP}$ = 3 V to 5.5 V, SCLK frequency = 20 MHz (unless otherwise noted)

|                       | PARAMETER                            |                  | TEST                     | CONDITIONS  | MIN             | TYP†                    | MAX        | UNIT |  |
|-----------------------|--------------------------------------|------------------|--------------------------|---|-----------------|-------------------------|------------|------|--|
| EL                    | Integral linearity error (II         | NL) (see Note 5) |                          |   |                 |                         | ±1.2       | LSB  |  |
| ED                    | Differential linearity erro          | r (DNL)          | See Note 4               |   |                 |                         | ±1         | LSB  |  |
|                       |                                      |                  |                          | Q Suffix  |                 |                         | ±2         |      |  |
| EO                    | Offset error (see Note 6)            | )                | See Note 4               | M Suffix, $T_A = 25^{\circ}C$<br>and $125^{\circ}C$ | -4              |                         | +6         | LSB  |  |
|                       |                                      |                  |                          | M Suffix, $T_A = -55^{\circ}C$                      | -4              |                         | +6.2       |      |  |
|                       |                                      |                  |                          | Q Suffix  |                 | ±1.1                    | <u>±</u> 4 |      |  |
| EFS                   | Full scale error (see Note 6)        |                  | See Note 4               | M Suffix, $T_A = 25^{\circ}C$<br>and $125^{\circ}C$ | -4              | ±1.1                    | +6         | LSB  |  |
|                       |                                      |                  |                          | M Suffix, $T_A = -55^{\circ}C$                      | -4              | ±1.1                    | +7.6       |      |  |
|                       |                                      |                  | SDI = B000h              |   | 800h<br>(2048D) |                         |            |      |  |
|                       | Self-test output code (se<br>Note 7) | e Table 1 and    | SDI = C000h              | SDI = C000h   |                 |                         |            |      |  |
|                       |                                      |                  | SDI = D000h              |   | FFFh<br>(4095D) |                         |            |      |  |
|                       |                                      | Internal OSC     | OSC = 3 MHz to           | 6 MHz   |                 | 3.2                     | 4.65       |      |  |
| <sup>t</sup> (conv)   | Conversion time                      | External SCLK    |                          |   | <u>(</u>        | $14 \times \text{DIV})$ |            | μs   |  |
| <sup>t</sup> (sample) | Sampling time                        | -                | With a maximum impedance | 600   |                 |                         | ns         |      |  |

TAII typical values are at  $T_A = 25^{\circ}C$ .

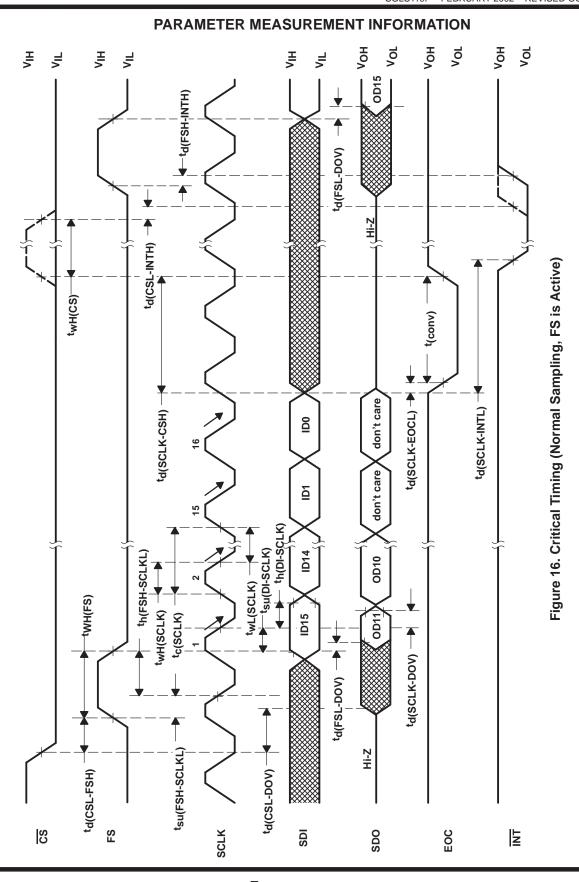
NOTES: 4. Analog input voltages greater than that applied to REFP convert as all ones (11111111111), while input voltages less than that applied to REFM convert as all zeros (00000000000).

5. Linear error is the maximum deviation from the best straight line through the A/D transfer characteristics.

6. Zero error is the difference between 00000000000 and the converted output for zero input voltage: full-scale error is the difference between 11111111111 and the converted output for full-scale input voltage.

7. Both the input data and the output codes are expressed in positive logic.

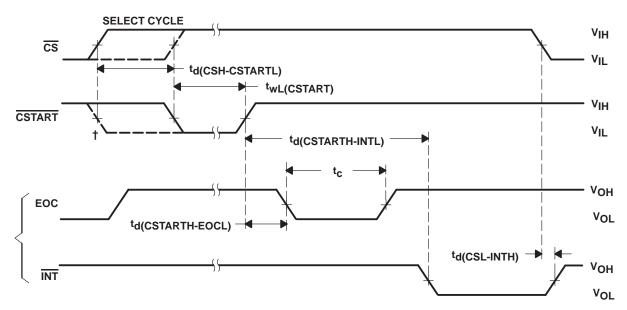




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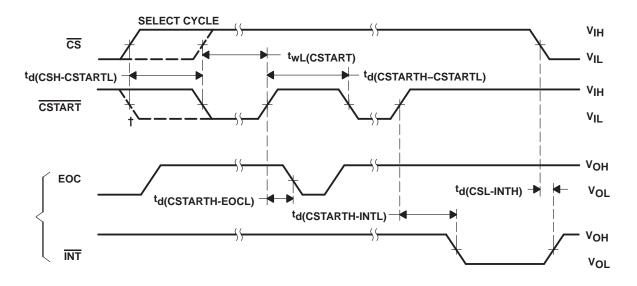
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#### PARAMETER MEASUREMENT INFORMATION

<sup>†</sup>CSTART falling edge may come before the rising edge of CS but no sooner than the fifth SCLK of the SELECT CYCLE.

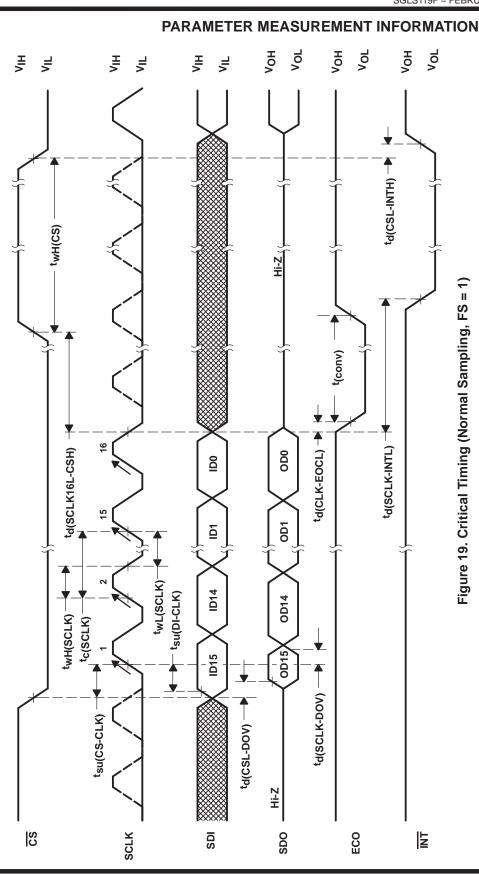
Figure 17. Critical Timing (Extended Sampling, Single Shot)



<sup>†</sup>CSTART falling edge may come before the rising edge of CS but no sooner than the fifth SCLK of the SELECT CYCLE.

Figure 18. Critical Timing (Extended Sampling, Repeat/Sweep/Repeat Sweep)

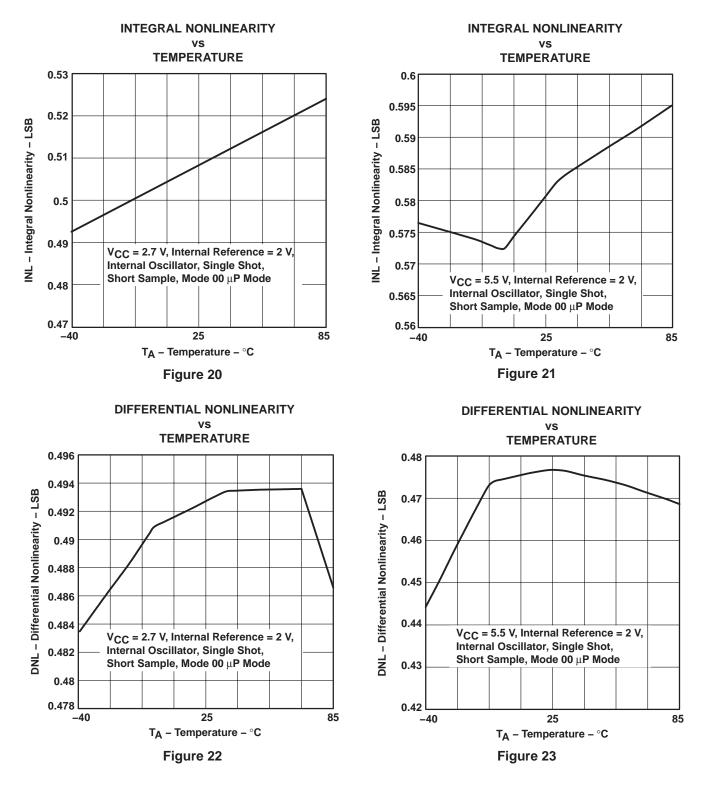




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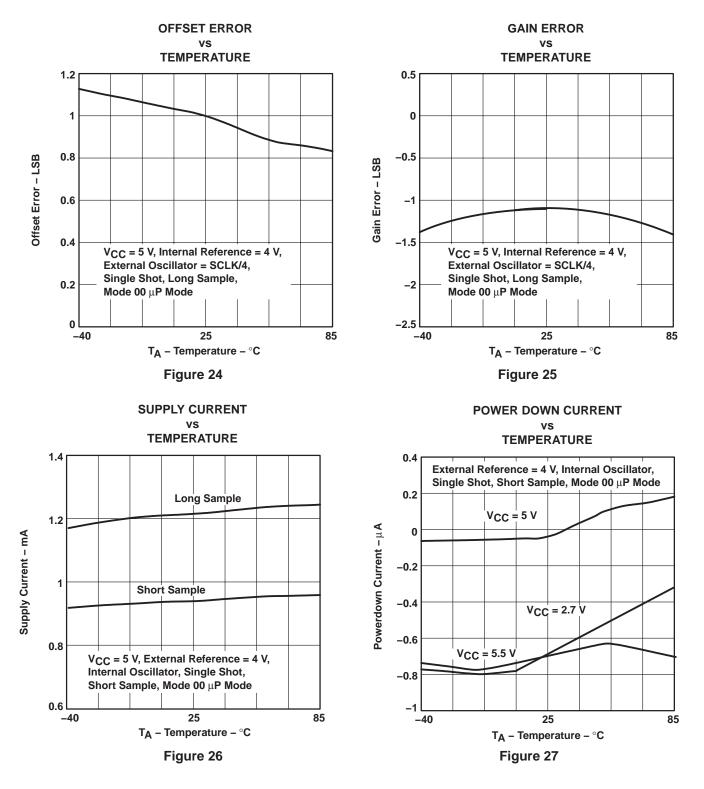
**ÈXAS** 

#### **TYPICAL CHARACTERISTICS**





#### **TYPICAL CHARACTERISTICS**

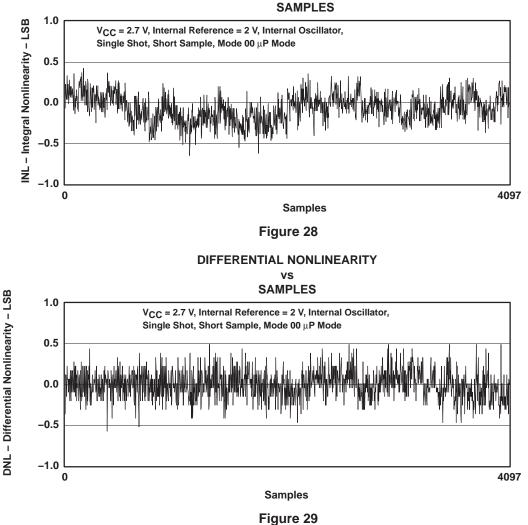




#### **TYPICAL CHARACTERISTICS**



٧S



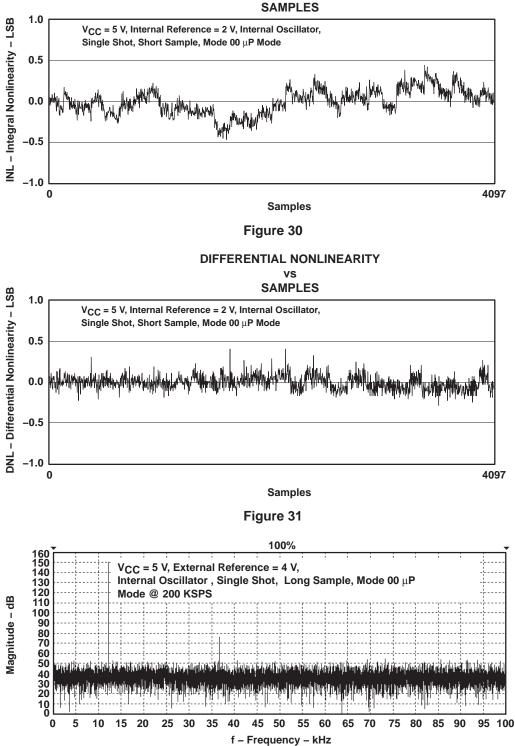


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#### **TYPICAL CHARACTERISTICS**



### vs

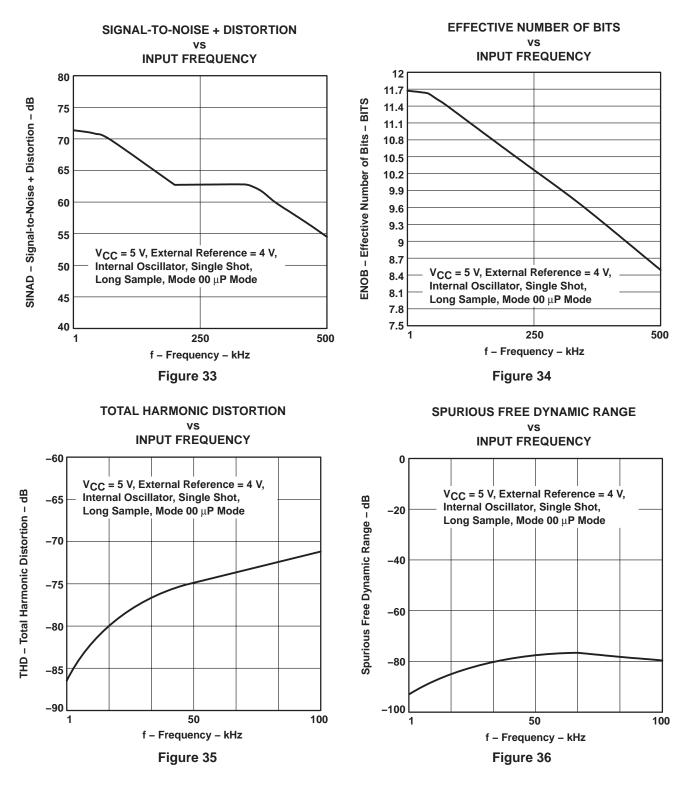




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#### TYPICAL CHARACTERISTICS





**PRINCIPLES OF OPERATION** 

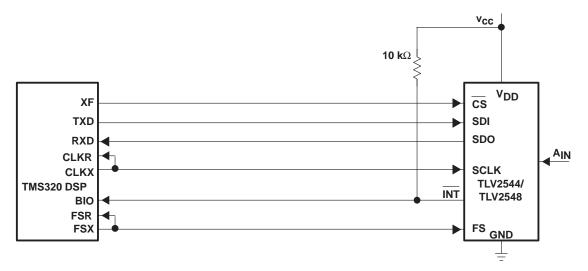


Figure 37. Typical Interface to a TMS320 DSP





#### PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)        | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5)                | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|------------------------|--------------------------------------|----------------------|--------------|--|---------|
| 5962-9957001Q2A  | ACTIVE        | LCCC         | FK                 | 20   | 55             | RoHS-Exempt<br>& Green | Call TI                              | N / A for Pkg Type   | -55 to 125   | 5962-<br>9957001Q2A<br>TLV2548<br>MFKB | Samples |
| TLV2544QD        | ACTIVE        | SOIC         | D                  | 16   | 40             | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | TLV2544QD                              | Samples |
| TLV2544QDG4      | ACTIVE        | SOIC         | D                  | 16   | 40             | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   |              | V2544QD                                | Samples |
| TLV2544QDR       | ACTIVE        | SOIC         | D                  | 16   | 2500           | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | TLV2544QD                              | Samples |
| TLV2548MFKB      | ACTIVE        | LCCC         | FK                 | 20   | 55             | RoHS-Exempt<br>& Green | Call TI                              | N / A for Pkg Type   | -55 to 125   | 5962-<br>9957001Q2A<br>TLV2548<br>MFKB | Samples |
| TLV2548QDW       | ACTIVE        | SOIC         | DW                 | 20   | 25             | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | TLV2548QDW                             | Samples |
| TLV2548QDWG4     | ACTIVE        | SOIC         | DW                 | 20   | 25             | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   |              | TLV2548QDW                             | Samples |
| TLV2548QDWR      | ACTIVE        | SOIC         | DW                 | 20   | 2000           | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | TLV2548QDW                             | Samples |
| TLV2548QDWRG4    | ACTIVE        | SOIC         | DW                 | 20   | 2000           | RoHS & Green           | NIPDAU                               | Level-1-260C-UNLIM   |              | TLV2548QDW                             | Samples |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



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### PACKAGE OPTION ADDENDUM

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF TLV2548M :

- Catalog : TLV2548
- Enhanced Product : TLV2548-EP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications



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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| */ | Il dimensions are nominal |                 |                    |    |      |                          |                          |            |            |            |            |           |                  |
|----|---------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
|    | Device                    | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| Γ  | TLV2544QDR                | SOIC            | D                  | 16 | 2500 | 330.0                    | 16.4                     | 6.5        | 10.3       | 2.1        | 8.0        | 16.0      | Q1               |
|    | TLV2548QDWR               | SOIC            | DW                 | 20 | 2000 | 330.0                    | 24.4                     | 10.8       | 13.3       | 2.7        | 12.0       | 24.0      | Q1               |



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# PACKAGE MATERIALS INFORMATION

14-Mar-2024



\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TLV2544QDR  | SOIC         | D               | 16   | 2500 | 350.0       | 350.0      | 43.0        |
| TLV2548QDWR | SOIC         | DW              | 20   | 2000 | 350.0       | 350.0      | 43.0        |

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#### TUBE



#### - B - Alignment groove width

#### \*All dimensions are nominal

| Device          | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | Τ (μm) | B (mm) |
|-----------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| 5962-9957001Q2A | FK           | LCCC         | 20   | 55  | 506.98 | 12.06  | 2030   | NA     |
| TLV2544QD       | D            | SOIC         | 16   | 40  | 505.46 | 6.76   | 3810   | 4      |
| TLV2544QDG4     | D            | SOIC         | 16   | 40  | 505.46 | 6.76   | 3810   | 4      |
| TLV2548MFKB     | FK           | LCCC         | 20   | 55  | 506.98 | 12.06  | 2030   | NA     |
| TLV2548QDW      | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |
| TLV2548QDWG4    | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# FK 20

#### 8.89 x 8.89, 1.27 mm pitch

# **GENERIC PACKAGE VIEW**

### LCCC - 2.03 mm max height

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





# **DW0020A**



# **PACKAGE OUTLINE**

#### SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



# DW0020A

# **EXAMPLE BOARD LAYOUT**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0020A

# **EXAMPLE STENCIL DESIGN**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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